

Notice of References Cited	Application/Control No. 10/521,885		Applicant(s)/Patent Under Reexamination AHN, KI SOON	
	Examiner Ajith Jacob		Art Unit 2109	Page 1 of 1

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*	B	US-6,418,308 B1	07-2002	Heinonen et al.	455/414
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NON-PATENT DOCUMENTS

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